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TO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 16739-002001

November 26, 2003

Application No. 10/723,774

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Applicant Wayne Lederer Filing Date

Group Art Unit

(37 CFR §1.98(b))

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 16739-002001	Application No. 10/723,774	
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